glycol (PEG) concentration on the structural characteristics of Uox uncomplexed and complexed with 8-azaxanthine (AZA) using powder diffraction data collected on ID31 [2] at the ESRF.

Previously unknown phases of Uox were observed depending on the presence and type of salt whereas PEG and pH variation had a minor affect on the cell dimensions. All phases have been successfully indexed, and the known I222 orthorhombic phase of Uox complexed with AZA was solved by molecular replacement using software designed for single crystal diffraction data [3]. The phase diagram of Uox and its relevant crystallizing conditions will be presented.

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# Keywords: protein crystallography; powder diffraction analysis; phase diagrams

## FA5-MS01-P14

Use of Rietveld Method in Quantitative Analysis of Weldments in Duplex Stainless Steels. Jorge L. Garin<sup>a</sup>, Rodolfo L. Mannheim<sup>a</sup>, Manuel A. Camus<sup>a</sup>. <sup>a</sup>Department of Metallurgical Engineering, Universidad de Santiago de Chile, Santiago, Chile. E-mail: jorge.garin@usach.cl

Duplex stainless steels (DSS) are an important class of engineering materials, currently been considered for welding applications among many other industrial requirements. They have approximately equal proportions of the bodycentered cubic ferrite and face-centered cubic austenite phases in their microstructure. The main advantage of DSS over conventional stainless steels are strength, chloride stress-corrosion cracking resistance and pitting corrosion resistance. Although the weldability of DSS is generally good, the high alloy content and the existence of a ferritic matrix render SDD susceptible to embritlement and loss of mechanical properties due to precipitation of sigma-phase in the microstructure. This phase is a complex intermetallic compound of Fe and Cr, based upon an ideal stoichiometric composition AX<sub>2</sub>, Pearson's code tP30 and space group  $P_2/$ mnm. Owing to the usually complex diffraction pattern of these alloys, which disclose many overlapping reflections and strong preferred orientations caused by the welding process, the Rietveld method was used to resolve those difficulties in welded joints of commercial duplex stainless steels (21-23 Cr - 4.5-6.5 Ni). The Rietveld refinements were performed based upon typical measurement and global parameters. The powder diffraction patterns of the weldments resulted in strong preferred orientation effects due to the uniaxial solidification of the weld metal-pool, which was corrected in the Rietveld refinement by using the March-Dollase function. The pseudo-Voigt function was used for the simulation of the peak shapes, while the background was modeled by a 3rd order polynomial in  $2\theta$  with refinable coefficients. A total of three phases, namely ferrite (Cr,Ni), austenite (Ni,Cr) and sigma phase  $(Fe_7Cr_6)$  were identified and considered in the quantitative analysis. The results obtained have assessed the application of the Rietveld method to quantify the microstructural components of weldments in duplex stainless steels. The main advantage of this methodology was the use of the March-Dollase model for correcting the strong texture effects on the diffraction pattern, which yielded the lower R-values and much better represented the relative amount of phases in the samples.

### Keywords: duplex stainless steel; rietveld; sigma phase

## FA5-MS01-P15

Laboratory X-ray Microdiffraction - Limits and Applications in Forensic Science. <u>Ivana</u> Jebavá<sup>a</sup>, Viktor Goliáš<sup>a</sup>, Marek Kotrlý<sup>b</sup>. *aInstitute of* Geochemistry, Mineralogy and Mineral Resources, Charles University in Prague. *bInstitute of* Criminalistics Prague. E-mail: Iva.Jebava@seznam.cz

The aim of this work was to evaluate and prove abilities and limits of laboratory x-ray powder microdiffraction and to create the methodical procedure for applying of this technique in forensic science.

X-ray powder microdiffraction is a progressive nondestructive analytical method that allows analysing very small area on a sample. X-ray beam was in our case focused by monocapillary with an exit diameter 100 or 800  $\mu$ m. Monocapillary is a hollow glass tube in which there is a total reflection of X-ray beam.

Several problems were investigated. Microdiffraction technique was compared with standard powder diffraction method in Bragg-Brentano instrumentation on identical small-volume samples and capabilities of identification of more phases in mixture were verified. Results showed that microdiffraction reflections are 2-3 times broader than the Bragg-Brentano ones (FWHM 0.13 vs. 0.27° 2 $\Theta$  for (012) line of corrundum). Peak shape can be fitted by conventional profile functions approach only with difficulties. However, in case of analysing of small-volume samples, microdiffraction technique usually identify more phases.

The next task was to determine limit of microdiffraction with respect to grain size in a sample. This was carried out on commercially produced alumina of several different granularities and results were compared with scans from imaging plate. Studied material contains pure alumina  $(\alpha$ -Al<sub>2</sub>O<sub>3</sub>) and minor concentration of  $\beta$ -Al<sub>2</sub>O<sub>3</sub> that was used for evaluation of quality of quantitative analyse from microdiffraction patterns. Upper grain size limit for 100 µm capillary was determined 10-15 µm (static sample) and 25 µm (rotated sample). For 800 µm capillary the upper granularity limit is 50 µm (static sample) and 100 µm (rotated sample).

The determination of detection limit of minority phase in mixture was our next step. We studied the mixture of quartz and fluorite in several concentrations. The detection limit was defined as 0,5 wt. % of fluorite.

The optimized step was defined  $0,05^{\circ}$  2 $\Theta$  for both 100

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and 800  $\mu$ m capillaries, and counting-time 2000 and 400 seconds/ step respectively. The results of this research will be used in routine forensic investigations in the Prague Institute of Criminalistics.

Keywords: X-ray diffraction; microdiffraction; forensic science

#### FA5-MS01-P16

Preferred Orientation and the Structure Analysis OfPolycrystalline Materials. Jürgen Grässlin<sup>a</sup>, Lynne B. McCusker<sup>a</sup>, Christian Baerlocher<sup>a</sup>, Fabia Gozzo<sup>b</sup>, Bernd Schmitt<sup>b</sup>. *aLaboratory of Crystallography, ETH Zurich, CH-8093 Zurich, Switzerland. bSwiss Light Source, PSI, CH-5232 Villigen, Switzerland.* E-mail: juergen.graesslin@mat.ethz.ch

If the crystallites in a polycrystalline sample are oriented, the intensity of a reflection will vary as a function of the orientation of the sample in the X-ray beam. This means that even if two reflections overlap in a conventional powder diffraction pattern (i.e. have the same *d*-value), their intensities are likely to vary differently as a function of sample orientation, so their individual intensities can be deduced if data are collected at different sample orientations. It has been shown that this principle can indeed be exploited to obtain more single-crystal-like data from a polycrystalline material [1]. Although the initial study was performed in reflection mode, it was soon realized that a transmission geometry offered several advantages and the experiment was adapted accordingly. In particular, the problem of sample homogeneity was eliminated (the sample is bathed in the X-ray beam), the severe correction of the data for the sample tilt was no longer necessary, and less synchrotron beamtime was required. To start with, a 2-dimensional image plate detector was used, but the resolution of the diffraction patterns, both in  $d_{min}$  (20 range) and in peak width proved to be a limitation [2]. To overcome this, the experiment was changed once again to accommodate the 1-dimensional Mythen I Si-microstrip detector that was available on the Materials Science Beamline at SLS [3,4]. Now, a new version of this detector, Mythen II, has become available, and further optimization of the experiment can be undertaken. The detector now has a  $2\theta$  range of  $120^{\circ}$  (vs. 60°), has a much larger dynamic range, and is not plagued by random dead and hot channels. Consequently, a different, more efficient, data collection strategy can be employed. Improvements in the data analysis software Maud [5] have also made it possible to reduce the data collection time. Constant 5° steps in the sample rotation ( $\phi$ ) and tilt ( $\chi$ ) angles are no longer required, so the number of sample orientations to be measured can be reduced from 1368 to 302 without sacrificing information content. The first measurements with the new detector and the new data collection strategy have now been performed. Textured samples of phlogopite mica and the aluminophosphate AlPO<sub>4</sub>-17 (ERI framework type), with known crystal structures, and of a niobium silicate with an unknown structure have been measured. Preliminary analysis of these data show that sensible orientation distribution functions can be derived, and the

full intensity extractions are in progress. The crystal system of the niobium silicate was ambiguous because unit cells in several different crystal systems (hexagonal, orthorhombic, monoclinic) were possible. The texture analysis has now shown that only the orthorhombic unit cell is consistent with the measured pole figures.

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Keywords: preferred orientation; structure determination; X-ray powder diffraction

#### FA5-MS01-P17

Effects of the Ferroelectric Domain Structure of PZT Ceramics on Powder Diffraction. <u>Kristin A.</u> <u>Schoenau<sup>a</sup></u>, Michael Knapp<sup>b</sup>, Matteo Leoni<sup>e</sup>, Hartmut Fuess<sup>a</sup>. *<sup>a</sup>Materials Science, Darmstadt University* of Technology, Germany. <sup>b</sup>CELLS, Barcelona, Spain. <sup>c</sup>Dept. Materials Engineering and Industrial Technologies, University of Trento, Italy. E-mail: kristin@cantab.net

Ferroelectric lead zirconate titanate solid solutions, PbZr<sub>1</sub>,  $_{x}Ti_{x}O_{3}$  (PZT), are frequently used in industrial applications exploiting the reaction of both the lattice and the domain structure to an applied electric field. Diffraction is a powerful and necessary tool to be able to understand materials reaction and to separate these two effects through analyzing intensity changes and shifts in peak position under electric field.

Highest strain is found for compositions at the morphotropic phase boundary (MPB) between the tetragonal and rhombohedral phase field. Discussions on its origin involved a coexistence of tetragonal and rhombohedral structures as well as the existence of a monoclinic phase [1]. Recent studies using high-resolution synchrotron x-ray powder diffraction in combination with TEM and EPR at ambient temperature [2, 3] were able to correlate XRD observation with a nanodomain structure. Theoretical approaches using Martensitic theory describe these observations with strong coherence effects between ordered nanodomains in diffraction experiments [4].

In XRPD anisotropic peak broadening effects and asymmetries in line shape for distinct hkl are already observed for single phase tetragonal material with a large domain size. But so far the asymmetry and intensity observed in between split reflection pairs have been attributed to diffuse scattering from strained domain walls [5], which is not in line with TEM observations [6].

We therefore analyze diffraction data of single phase tetragonal and rhombohedral PZT in the vicinity of the MPB recorded in transmission mode at the beamline B2, Hasylab, Hamburg Germany, using Rietveld refinement and size-strain analysis to be able to determine a sound basis for analysis of diffraction data of morphotropic PZT samples.

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